

L Number	Hits	Search Text	DB	Time stamp
-	2	("4717445").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/23 16:20
-	50	(monitoring or control) with (etch\$4 adj bias)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/23 16:21
-	10	((monitoring or control) with (etch\$4 adj bias)) and calculat\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/23 16:22
-	6	((((monitoring or control) with (etch\$4 adj bias)) and calculat\$4) and capacit\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 09:50
-	6	((((monitoring or control) with (etch\$4 adj bias)) and calculat\$4) and capacit\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 11:58
-	140	measur\$4 with capacit\$5 with cathode with anode	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 14:20
-	0	(measur\$4 with capacit\$5 with cathode with anode) and ((secong adj2 anode) with (second cathode))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 12:09
-	1003	measur\$4 same capacit\$5 same cathode same anode	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 12:09
-	310	(measur\$4 same capacit\$5 same cathode same anode) and (second with cathode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 12:10
-	0	((measur\$4 same capacit\$5 same cathode same anode) and (second with cathode)) and ((secong adj2 anode) with (second cathode))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 12:10
-	94	(measur\$4 same capacit\$5 same cathode same anode) and (second adj3 cathode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 13:21
-	20	(measur\$4 same capacit\$5 same cathode same anode) and (second adj cathode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 12:11

	6	(measur\$4 same capacit\$5 same cathode same anode) and ((second adj cathode) with (second adj anode))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 14:12
	0	((measur\$4 same capacit\$5 same cathode same anode) and ((second adj cathode) with (second adj anode))) and calcul\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 13:20
	296	(measur\$4 same capacit\$5 same cathode same anode) and calcul\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 13:22
	34	((measur\$4 same capacit\$5 same cathode same anode) and (second adj3 cathode)) and calcul\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 13:22
	485	etch\$4 adj bias	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 13:25
	3	(etch\$4 adj bias) and (unit with area with capacit\$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 13:44
	0	(measur\$4 same capacit\$5 same cathode same anode) and ((second adj cathode) with (second adj anode)) and (test near3 apparatus)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 14:13
	1	(etch\$4 adj bias) and (test near3 apparatus)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 14:18
	161	(etch\$4 adj bias) and apparatus	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 14:18
	62	(measur\$4 with capacit\$5 with cathode with anode) and apparatus	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/24 14:20